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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 09/763,914
Applicant : STAHLER et al.
Filed : May 11, 2001
TC/A.U. : 1639
Examiner : Padmashri Ponnaluri

Docket No. : 2923-438
Customer No. : 06449
Confirmation No. : 3624

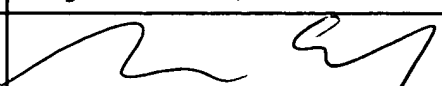
INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent
and Trademark Office
P.O. Box 1450
Alexandria, Virginia 22313-1450

Dear Sir:

Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant submits herewith information that the Office may wish to consider in examination of the subject application. Materials submitted for consideration are listed on the attached form PTO-1449. German language documents are cited because they were cited in related cases or similar cases having the same assignee in the United States or in Germany. English-language equivalents or abstracts are also submitted where available.

Applicants believe that no fee is due for this submission, however, if the Office deems a fee necessary, the Office is authorized to charge deposit account number 02-2135.

RESPECTFULLY SUBMITTED,					
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

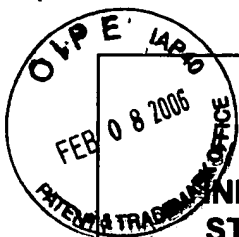
				Complete if Known	
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				Examiner Name	Padmashri Ponnaluri
				Confirmation No.	3624
Sheet	1	of	6	Attorney Docket Number	2923-438

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code ² (if known)		
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.



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		Office ³ Code	Number ⁴	Kind ⁵ (if known)			
		WO	91/18276	A1	Kelly et al.	11-28-1991	
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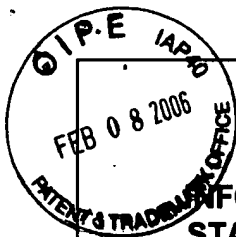
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		Office ³ Code	Number ⁴	Kind ⁵ (if known)			
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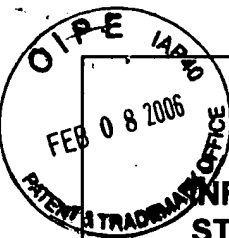
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		JP	9288080		Shinnitsuka Kankyo Eng KK (Abstract Only)	11-04-1997	AB
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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²	
		Hanley, et al. "Charge Transfer Device in Analytical Instrumentation," Anal. Chem. 68:A661-A667, 1996.		
		Johnson et al., "Micromirror arrays perform photolithography step," EETIMES.com, (1999), 2 pgs.		
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		German Search Report of 08/9/1999, from DE 19839254.0 (with English translation).	✓	
		German Search Report of 04/17/2000, from DE 19940752.5 (with English translation).	✓	
Examiner Signature				Date Considered

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